Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/604,836	LEE, SZETSEN	STEVEN
Examiner	Art Unit	
Eric B. Chen	1765	

SEARCHED					
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	<u>.</u>				

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Performed inventor search for double patenting (PALM)	7/1/2005	EC
EAST (all databases) - see search history printout	7/1/2005	EC
216/61,67; 438/9,10,706,714, 715,719,723,724; 156/345.24 (text search only - see search history printout)(consulted Kin Chen)	7/6/2005	EC